

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 251137US0RD DIV		SERIAL NO. <u>10/814,257</u> New Application		
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshiyuki KAMATA, et al.				
				FILING DATE Herewith		GROUP <u>1763</u>		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
<u>Heu</u>	AA	6,303,277	10/2001	Heida et al				
	AB	5,820,769	10/1998	Chou				
	AC	6,168,845	01/2001	Fontana et al				
	AD	6,197,399	03/2001	Naito et al				
	AE	6,125,095	09/2000	Gemma et al				
	AF	5,091,225	02/1992	Goto				
<u>Heu</u>	AG	5,998,040	12/1999	Nakatani et al				
	AH							
	AI							
	AJ							
	AK							
	AL							
	AM							
	AN							
	FOREIGN PATENT DOCUMENTS							
			DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<u>Heu</u>	AO	05-205257	08/1993	Japan				
	AP	2000-195200	07/2000	Japan				
	AQ	06-333230	02/1994	Japan				
<u>Heu</u>	AR	2001-134937	05/2001	Japan				
	AS							
	AT							
	AU							
	AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
<u>Heu</u>	AW	S.E. Lambert, et al, IEEE Transactions on Magnetics, vol. 25, no. 5, pp. 3381-3383, 1989						
	AX							
	AY							
	AZ							
Examiner <u>Alta Olan</u>					<input type="checkbox"/> Additional References sheet(s) attached Date Considered <u>9-30-05</u>			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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251137US0RD DIVSERIAL NO.
10/814,257LIST OF REFERENCES CITED BY APPLICANT²APPLICANT
Yoshiyuki KAMATA, et al.FILING DATE
April 1, 2004GROUP
~~2652~~ 1763

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>AW</i>	AA	US 2004-0191557	09-30-04	KAMATA et al.			
	AB						
	AC						
	AD						
	AE						
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	AH						
	AI						
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	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AQ					
	AP					
	AQ					
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	AU					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
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☐ Additional References sheet(s) attachedExaminer *Alan O'Leary*

Date Considered 9-30-05

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